

(19) World Intellectual Property  
Organization  
International Bureau



(43) International Publication Date  
9 June 2005 (09.06.2005)

PCT

(10) International Publication Number  
**WO 2005/052509 A1**

(51) International Patent Classification<sup>7</sup>: **G01B 15/02**,  
G06M 9/00

(21) International Application Number:  
PCT/JP2004/017670

(22) International Filing Date:  
22 November 2004 (22.11.2004)

(25) Filing Language: English

(26) Publication Language: English

(30) Priority Data:  
2003-393248 25 November 2003 (25.11.2003) JP

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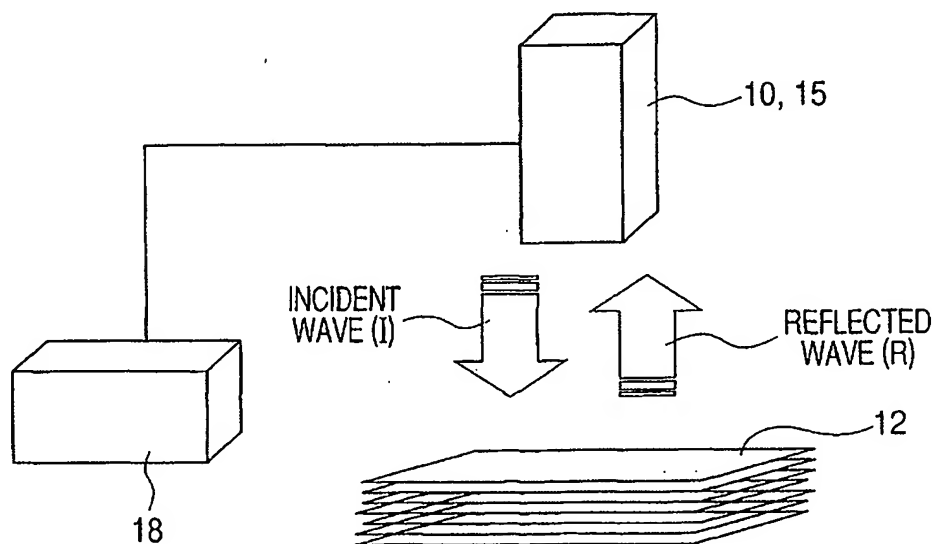
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(81) Designated States (unless otherwise indicated, for every  
kind of national protection available): AE, AG, AL, AM,  
AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN,  
CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI,  
GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, KE, KG,  
KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG,  
MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH,  
PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN,  
TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

(84) Designated States (unless otherwise indicated, for every  
kind of regional protection available): ARIPO (BW, GH,  
GM, KE, LS, MW, MZ, NA, SD, SI, SZ, TZ, UG, ZM,  
ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM),  
European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI,  
FR, GB, GR, HU, IE, IS, IT, LU, MC, NL, PL, PT, RO, SE,

[Continued on next page]

(54) Title: SYSTEM AND METHOD FOR COUNTING THE NUMBER OF LAYERS OF A MULTILAYER OBJECT BY  
MEANS OF ELECTROMAGNETIC WAVES



(57) Abstract: A system or method is adapted for counting the number of layers of a multilayer object such as a stack of paper. An electromagnetic wave is caused to strike the surface of the multilayer object. Signals of the waves generated by reflection at the respective interfaces of the layers are evaluated to count the number of layers. Alternatively, the phase of the electromagnetic wave transmitted through the multilayer object, is evaluated to determine the number of layers. It is proposed to use frequencies from 30 GHz to 100 THz, i.e. microwaves, millimeter waves and infrared waves.